

**Search Notes**

Application/Control No.

10/830,150

Examiner

David E. Martinez

Applicant(s)/Patent under  
Reexamination

IZAWA ET AL.

Art Unit

2181

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East see attached	5/17/2007	DM
710/33,36,62,65,72.ccls. 705/35,43.ccls. 902/8,10.ccls.with keywords and text search	5/17/2007	DM
inventor search east/palm	5/17/2007	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	5/17/2007	DM